



INTELLECTUAL PROPERTY
402-391-4446

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JUN 19 2003
TECHNOLOGY CENTER 2800

June 14, 2003

Commissioner for Patents
BOX: 1450
Alexandria, VA 22313-1450

RE: PUBLISHED APPLICATION OF KWON TITLED: "METHODS AND APPARATUS
FOR DETERMINING OPTICAL CONSTANTS OF SEMICONDUCTORS AND
DIELECTRICS WITH INTERBAND STATES";
PUB. NO. US2003/0073254A1;
PUB. DATE: APR. 17, 2003;
APPL. NO. 09/333,838

OPPOSITION

Dear Sir;

Accompanying herewith is a check for \$180.00, a Listing of,
and copies of materials we feel should be considered in the
examination of the identified Patent Application.

LISTING

Patent No. 4,332,833, Serial No. 126,217, Issued Jun. 1, 1982 to
Aspnes et al.

Patent No. 6,362,881 B1 to Pickering et al., Serial No.
09/297,819, Issued Mar. 26, 2002.

"Modeling the Optical Dielectric Function of Semiconductors:
Extension of the Critical-Point Parabolic-Band Approximation";
Kim, Physical Rev.B, Vol. 45, No. 20, (May 1992).

"Parameterization of the Optical Functions of Amorphous Materials
in the Interband Region", Jellison et al., Appl. Phys. Lett.
69(3) (July 1996).

"Optical Dispersion Relations for Amorphous Semiconductor and
Amorphous Dielectrics", Forouhi & Bloomer, Phys. Rev. B, Vol. 34,
No. 10, (Nov. 1986).

"Optical Dispersion Relations for Si and Ge", Adachi, J. App.
Phys. 66(7), (Oct. 1989).

From Optical Metrology, "Overview of Variable Angle Spectroscopic
Ellipsometry (VASE)", Part II, Johns et al., Soc. Photo-Opt.
Instrum. Eng. (1999).



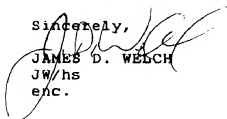
"Optical Properties of Bulk and Thin-Film Sr-TiO₂ on Si and PT", Zollner et al., J. Vac. Sci. Technol. B 19(4) (2000).

From Wiley Encyclopedia of Electrical and Electronics Engineering---Supplement 1, Editor Webster, John Wiley & Sons, (2000).

"Development of a Parametric Optical Constant Model for Hg_{1-x}Cd_xTe for Control of Composition by Spectroscopic Ellipsometry During MBE Growth", Johns et al., Thin Solid Films, 313-314 (1998).

Service was made on the Applicant's Attorney, Antonelli Terry Stout and Kraus at Suite 1800, 1300 North Seventeenth Street, Arlington, VA 22209, via First Class Mail sent on June 14, 2003

Sincerely,


JAMES D. WELCH

JW/hs

enc.